Sample Results Summary Sheet Please return this form to the Curator for each allocated Sample

Sample ID: RA-QD02-0032

PI: Tomoki Nakamura

Type and date of analysis performed:

XRD	Jan/28/2011~ Feb/3/2011
SEM	Feb/7/2011

Elements or phases identified: (Mg, Si, olivine, pyroxene, aromatic carbon, etc.) XRD : OI, PI, HPx SEM : OI, PI, HPx, Tr

Contaminant phases identified: (AI, SUS, carbon particles, etc.) N/A

Sample handling:

XRD Attached to carbon fiber with resin.

SEM

Exposed in atmosphere. Polished by M cross C-coated (20 nm)

State of sample pre-analysis:

Attached to carbon fiber with resin. (XRD) Polished section with resin embedded (SEM)

State of sample post-analysis:

Attached to carbon fiber with resin. (XRD) Polished section with resin embedded, C-coated (SEM) N_2 hold in sample holder. **Analysis data Notes:** (summary of the attached analysis data and/or images) See attached sheets.

RA-QD02-0032

 Analysis
 S-XRD
 (polish)
 SEM (Ibaraki)

 Present status
 Putted butt with a large hole by FIB sampling



